Search Notes			

Application/Control No.	Applicant(s)/Patent t	Applicant(s)/Patent under Reexamination	
10/531,319	MATSUOKA ET AL	MATSUOKA ET AL.	
Examiner	Art Unit		
Deborah Yee	1742		

SEARCHED			
Class	Subclass	Date	Examiner
148	318 206-238	2/16/2007	DY
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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